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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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Small Signal MOSFET

30 V, 245 mA, Dual, N-Channel, Gate ESD Protection, 2x2 WDFN Package

Features

- Optimized Layout for Excellent High Speed Signal Integrity
- Low Gate Charge for Fast Switching
- Small 2 x 2 mm Footprint
- ESD Protected Gate
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit
Drain-to-Source Voltage		V_{DSS}	30	V
Gate-to-Source Voltage		V _{GS}	±10	V
Continuous Drain Current (Note 1)	Steady State = 25°C	I _D	245	mA
Power Dissipation (Note 1)	Steady State = 25°C	P _D	755	mW
Pulsed Drain Current $t_P \le 10 \mu s$		I _{DM}	1.2	Α
Operating Junction and Storage Temperature		T _J , T _{STG}	-55 to 150	°C
Continuous Source Current (Body Diode)		I _{SD}	245	mA
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	166	°C/W

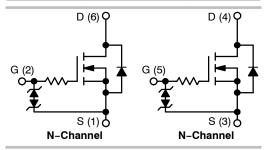
^{1.} Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).



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V _{(BR)DSS}	R _{DS(on)} Typ @ V _{GS}	I _D MAX (Note 1)
30 V	1.4 Ω @ 4.5 V	0.45 1
30 V	2.3 Ω @ 2.5 V	245 mA



MARKING DIAGRAM

WDFN6 CASE 506AN



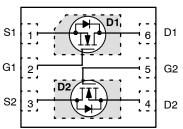
JG = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

PIN CONNECTIONS



(Top View)

ORDERING INFORMATION

Device	Package	Shipping [†]
NVLJD4007NZTAG	WDFN6 (Pb-Free)	3000/Tape & Reel
NVLJD4007NZTBG	WDFN6 (Pb-Free)	3000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	30			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	Reference to 25°C, I _D = 100 μA		27		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 30 V			1.0	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 20 V, T = 85 °C			1.0	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 10 \text{ V}$			±25	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$			±1.0	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±5 V T = 85 °C			±1.0	μΑ	
ON CHARACTERISTICS (Note 2)	•			•			
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS} = V_{GS}, I_D = 100 \mu A$	0.5	1.0	1.5	V	
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	Reference to 25°C, I _D = 100 μA		-2.5		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 125 \text{ mA}$		1.4	7.0	Ω	
		V _{GS} = 2.5 V, I _D = 125 mA		2.3	7.5		
Forward Transconductance	9FS	$V_{DS} = 3 \text{ V, } I_D = 125 \text{ mA}$		80		mS	
CAPACITANCES & GATE CHARGE							
Input Capacitance	C _{ISS}			12.2	20		
Output Capacitance	C _{OSS}	$V_{DS} = 5.0 \text{ V, f} = 1 \text{ MHz,} $ $V_{GS} = 0 \text{ V}$		10	15	pF	
Reverse Transfer Capacitance	C _{RSS}	. do		3.3	6.0		
Total Gate Charge	Qg			0.75			
Gate-to-Source Charge	Q_{gs}	$V_{DS} = 24 \text{ V}, I_{D} = 100 \text{ mA}, $ $V_{GS} = 4.5 \text{ V}$		0.20		nC	
Gate-to-Drain Charge	$Q_{ m gd}$	V _{GS} = 4.5 V		0.20			
Plateau Voltage	V_{GP}			1.57		V	
SWITCHING CHARACTERISTICS (Note 3)							
Turn-On Delay Time	t _{d(ON)}			9		ns	
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 24 \text{ V},$		41		ns	
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 125 \text{ mA}, R_G = 10 \Omega$		96			
Fall Time	t _f			72			
DRAIN-SOURCE DIODE CHARACTERISTICS	3						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V, } I_{S} = 125 \text{ mA}$		0.79	0.9	V	

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

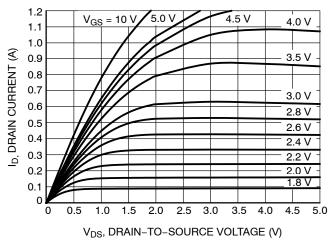


Figure 1. On-Region Characteristics

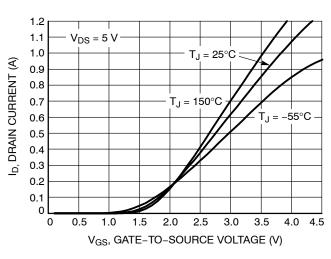


Figure 2. Transfer Characteristics

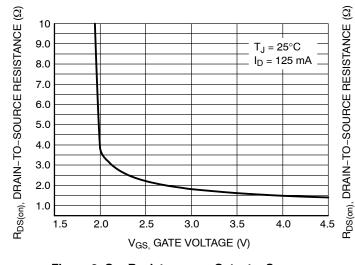


Figure 3. On-Resistance vs. Gate-to-Source Voltage

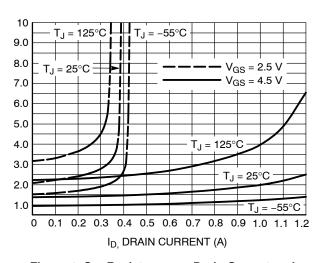


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

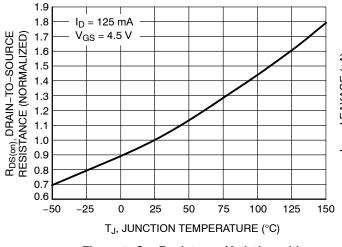


Figure 5. On–Resistance Variation with Temperature

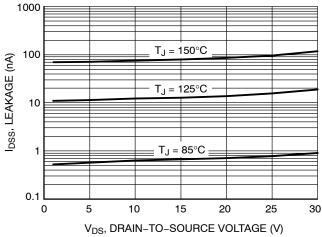
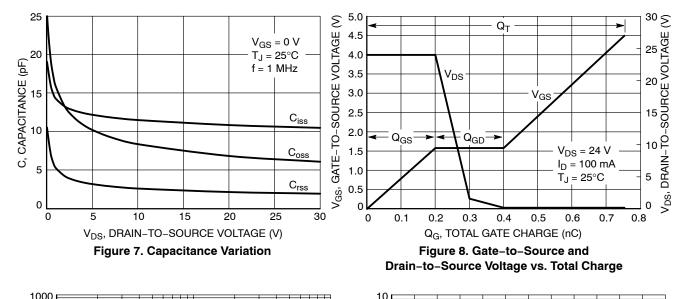


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES



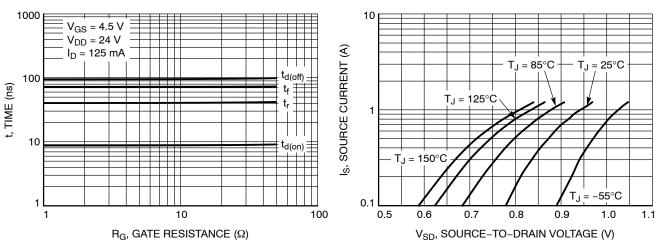


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

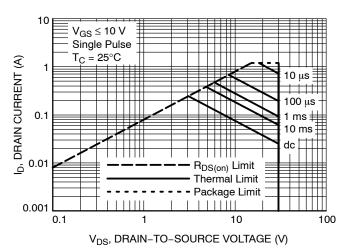


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL PERFORMANCE CURVES

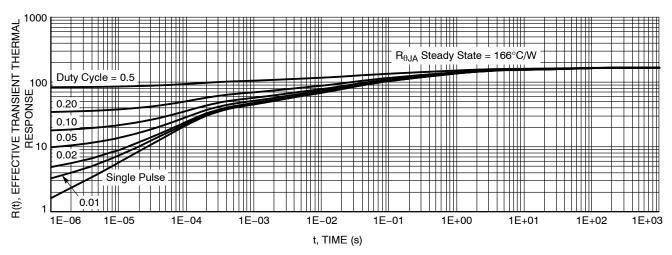
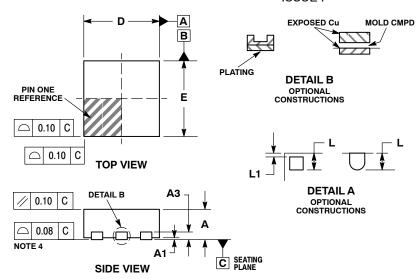


Figure 12. Thermal Impedance (Junction-to-Ambient)

PACKAGE DIMENSIONS

WDFN6 2x2, 0.65P

CASE 506AN ISSUE F

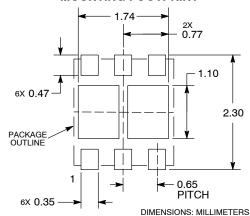


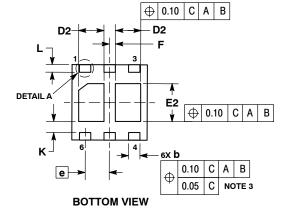
- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 - DIMENSION b APPLIES TO PLATED
- TERMINAL AND IS MEASURED BETWEEN
 0.15 AND 0.30 mm FROM THE TERMINAL TIP. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

FAD AS WELL AS THE TENIV					
	MILLIMETERS				
DIM	MIN MAX				
Α	0.70	0.80			
A1	0.00	0.05			
A3	0.20 REF				
b	0.25	0.35			
D	2.00 BSC				
D2	0.57	0.77			
E	2.00 BSC				
E2	0.90	1.10			
е	0.65 BSC				
F	0.15 BSC				
K	0.25 REF				
L	0.20	0.30			
14		0.40			

STYLE 3:

- PIN 1. SOURCE 1
 - 2. GATE 1
 - SOURCE 2 3
 - DRAIN 2 4.
 - GATE 2 DRAIN 1
- **SOLDERMASK DEFINED MOUNTING FOOTPRINT**





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